BUK762R0-40C

N-channel TrenchMOS standard level FET

Rev. 02 — 20 August 2007

Product data sheet

1. Product profile

1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using Philips Ultra High-Performance Automotive (UHP) TrenchMOS technology. This product has been designed and qualified to the appropriate AEC standard for use in Automotive critical applications.

1.2 Features

- 175 °C rated
- Q101 compliant

- Low on-state resistance
- Standard level compatible

1.3 Applications

- 12 V loads
- General purpose power switching
- Automotive systems
- Motors, lamps, solenoids

1.4 Quick reference data

Table 1. Quick reference

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
I_D	drain current	V_{GS} = 10 V; T_{mb} = 25 °C; see <u>Figure 1</u> and <u>4</u>	[1][2]	-	-	100	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>		-	-	333	W
Static ch	aracteristics						
R _{DSon}	drain-source on-state resistance	V_{GS} = 10 V; I_D = 25 A; T_j = 25 °C; see <u>Figure 13</u> and <u>12</u>		-	1.7	2	mΩ
Avalanch	ne ruggedness						
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	$\begin{split} I_D &= 100 \text{ A; } V_{\text{sup}} \leq 40 \text{ V;} \\ R_{\text{GS}} &= 50 \Omega; V_{\text{GS}} = 10 \text{ V;} \\ T_{j(\text{init})} &= 25 ^{\circ}\text{C; inductive load} \\ \text{type unclamped inductive load} \end{split}$		-	-	1.2	J

^[1] Continuous current is limited by package.



^[2] Refer to document 9397 750 12572 for further information.

2. Pinning information

Table 2. Pinning

Pin	Symbol	Description	Simplified ou	utline	Graphic Symbol	
1	G	gate		mb	D	
2	D	drain	[1]			
3	S	source		i i	$G \longrightarrow \overline{A}$	
mb	D	mounting base; connected to drain		3 4 (D2PAK)	mbb076 S	

^[1] It is not possible to make a connection to pin 2.

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BUK762R0-40C	D2PAK	plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped)	SOT404

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

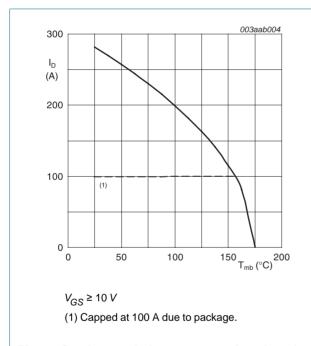
Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage	$T_j \ge 25$ °C; $T_j \le 175$ °C	-	40	V
V_{DGR}	drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega$	-	40	V
V_{GS}	gate-source voltage		-20	20	V
I_D	drain current	T_{mb} = 25 °C; V_{GS} = 10 V; see <u>Figure 1</u> and <u>4</u>	<u>[1]</u> -	276	Α
		T _{mb} = 100 °C; V _{GS} = 10 V; see <u>Figure 1</u>	[2][3]	100	А
		$T_{mb} = 25 ^{\circ}C; V_{GS} = 10 V; \text{ see } \underline{\text{Figure 1}} \text{ and } \underline{4}$	[2][3]	100	Α
I _{DM}	peak drain current	T_{mb} = 25 °C; $t_p \le 10$ μs; duty type pulsed; see Figure 4	-	1104	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	333	W
T _{stg}	storage temperature		-55	175	°C
Tj	junction temperature		-55	175	°C
Avalanc	ne ruggedness				
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	I_D = 100 A; V_{sup} ≤ 40 V; R_{GS} = 50 Ω; V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; inductive load type unclamped inductive load	-	1.2	J
E _{DS(AL)R}	repetitive drain-source avalanche energy	see <u>Figure 3</u>	[4][5] <u> </u>	-	J

Limiting values ...continued Table 4.

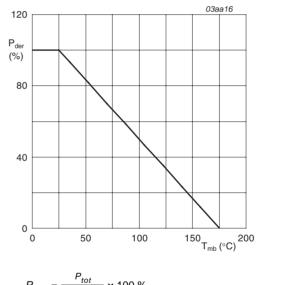
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symb	ol Parameter	Conditions	Min	Max	Unit
Sourc	e-drain diode				
Is	source current	T _{mb} = 25 °C	<u>[1]</u> _	276	Α
		T _{mb} = 25 °C	[2][3]	100	Α
I _{SM}	peak source current	$t_p \le 10~\mu s;$ duty type pulsed; $T_{mb} = 25~^{\circ}C$	-	1104	Α

- [1] Current is limited by power dissipation chip rating.
- Continuous current is limited by package. [2]
- Refer to document 9397 750 12572 for further information. [3]
- Maximum value not quoted. Repetitive rating defined in avalanche rating figure. [4]
- Single-pulse avalanche rating limited by maximum junction temperature of 175 °C. [5]
- Repetitive avalanche rating limited by an average junction temperature of 170 °C.
- Refer to application note AN10273 for further information.

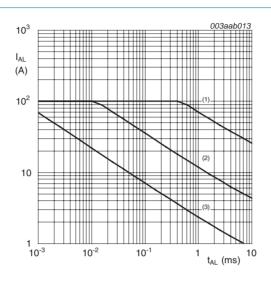


Continuous drain current as a function of Fig 1. mounting base temperature



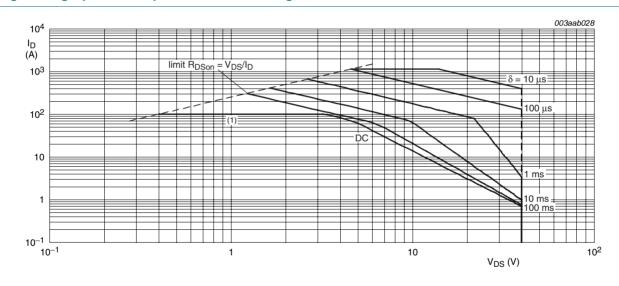
 $P_{der} = \frac{P_{tot}}{P_{tot(25\,^{\circ}\text{C})}} \times 100\,\%$

Fig 2. Normalized total power dissipation as a function of mounting base temperature



- (1) Single-pulse; T_{mb} = 25 °C.
- (2) Single-pulse; $T_{mb} = 150 \, ^{\circ}C$.
- (3) Repetitive.

Fig 3. Single-pulse and repetitive avalanche rating; avalanche current as a function of avalanche time



 T_{mb} = 25 °C; I_{DM} is single pulse

(1) Capped at 100 A due to package.

Fig 4. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{\text{th(j-a)}}$	thermal resistance from junction to ambient	mounted on a printed-circuit board; minimum footprint; vertical in still air	-	50	-	K/W
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	see <u>Figure 5</u>	-	-	0.45	K/W

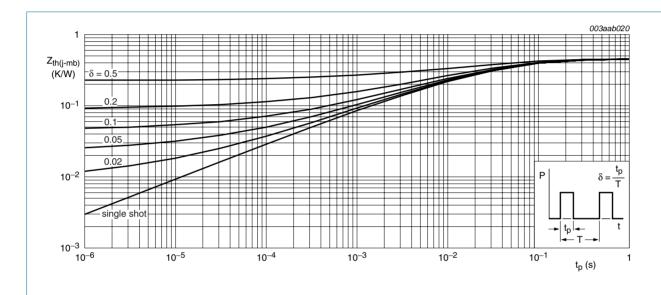


Fig 5. Transient thermal impedance from junction to mounting base as a function of pulse duration

6. Characteristics

Table 6. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static char	acteristics					
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V};$ $T_j = 25 ^{\circ}\text{C}$	40	-	-	V
		$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V};$ $T_j = -55 \text{ °C}$	36	-	-	V
V _{GSth}	gate-source threshold voltage	I_D = 1 mA; V_{DS} = V_{GS} ; T_j = 25 °C; see Figure 10	2	3	4	V
		$I_D = 1$ mA; $V_{DS} = V_{GS}$; $T_j = -55$ °C; see <u>Figure 11</u>	-	-	4.4	V
		I_D = 1 mA; V_{DS} = V_{GS} ; T_j = 175 °C; see <u>Figure 11</u>	1	-	-	V
I _{DSS} drain leakage curren		V_{DS} = 40 V; V_{GS} = 0 V; T_j = 25 °C	-	0.02	1	μΑ
		$V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V};$ $T_j = 175 \text{ °C}$	-	-	500	μА

Table 6. Characteristics ... continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I_{GSS}	gate leakage current	V_{DS} = 0 V; V_{GS} = 20 V; T_{j} = 25 $^{\circ}C$	-	2	100	nA
		$V_{DS} = 0 \text{ V}; V_{GS} = -20 \text{ V};$ $T_j = 25 ^{\circ}\text{C}$	-	2	100	nA
R_{DSon}	drain-source on-state resistance	V_{GS} = 10 V; I_D = 25 A; T_j = 175 °C; see <u>Figure 12</u> and <u>13</u>	-	-	3.75	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 25 ^{\circ}\text{C};$ see <u>Figure 13</u> and <u>12</u>	-	1.7	2	mΩ
Source-dr	ain diode					
V_{SD}	source-drain voltage	$I_S = 25 \text{ A}$; $V_{GS} = 0 \text{ V}$; $T_j = 25 ^{\circ}\text{C}$; see Figure 16	-	0.85	1.2	V
t _{rr}	reverse recovery time	$I_S = 20 \text{ A; } dI_S/dt = -100 \text{ A/}\mu\text{s;}$ $V_{GS} = -10 \text{ V; } V_{DS} = 30 \text{ V;}$ $T_j = 25 \text{ °C}$	-	75	-	ns
Q _r	recovered charge	$I_S = 20 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s};$ $V_{GS} = -10 \text{ V}; V_{DS} = 30 \text{ V};$ $T_j = 25 ^{\circ}\text{C}$	-	57	-	nC
Dynamic o	characteristics					
Q _{G(tot)}	total gate charge	$I_D = 25 \text{ A}; V_{DS} = 32 \text{ V};$ $V_{GS} = 10 \text{ V}; T_j = 25 ^{\circ}\text{C};$ see <u>Figure 14</u>	-	175	-	nC
Q_{GS}	gate-source charge	$I_D = 25 \text{ A}; V_{DS} = 32 \text{ V};$ $V_{GS} = 10 \text{ V}; T_j = 25 ^{\circ}\text{C};$ see Figure 14	-	38	-	nC
Q_{GD}	gate-drain charge	$I_D = 25 \text{ A}; V_{DS} = 32 \text{ V};$ $V_{GS} = 10 \text{ V}; T_j = 25 ^{\circ}\text{C};$ see Figure 14	-	67	-	nC
C _{iss}	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V};$ $f = 1 \text{ MHz}; T_j = 25 ^{\circ}\text{C};$ see Figure 15	-	8492	11323	pF
C _{oss}	output capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V};$ $f = 1 \text{ MHz}; T_j = 25 ^{\circ}\text{C};$ see Figure 15	-	1606	1927	pF
C _{rss}	reverse transfer capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V};$ $f = 1 \text{ MHz}; T_j = 25 ^{\circ}\text{C};$ see Figure 15	-	1101	1508	pF
t _{d(on)}	turn-on delay time	$V_{DS} = 30 \text{ V}; R_L = 1.2 \Omega;$ $V_{GS} = 10 \text{ V}; R_{G(ext)} = 10 \Omega;$ $T_j = 25 \text{ °C}$	-	65	-	ns
t _r	rise time	$\begin{split} &V_{DS}=30 \text{ V; } R_L=1.2 \Omega; \\ &V_{GS}=10 \text{ V; } R_{G(ext)}=10 \Omega; \\ &T_j=25 \text{ °C} \end{split}$	-	133	-	ns
$t_{d(off)}$	turn-off delay time	$\begin{split} &V_{DS}=30 \text{ V; } R_L=1.2 \Omega; \\ &V_{GS}=10 \text{ V; } R_{G(ext)}=10 \Omega; \\ &T_j=25 \text{ °C} \end{split}$	-	146	-	ns

Table 6. Characteristics ... continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
t _f	fall time	$V_{DS} = 30$ V; $R_{L} = 1.2$ Ω; $V_{GS} = 10$ V; $R_{G(ext)} = 10$ Ω; $T_{j} = 25$ °C	-	119	-	ns
L _D	internal drain inductance	from upper edge of drain mounting base to centre of die; $T_j = 25 ^{\circ}\text{C}$	-	2.5	-	nΗ
L _S	internal source inductance	from source lead 6 mm from package to source bond pad; $T_j = 25 ^{\circ}\text{C}$	-	7.5	-	nΗ

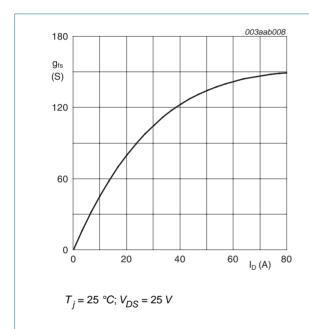


Fig 6. Forward transconductance as a function of drain current; typical values

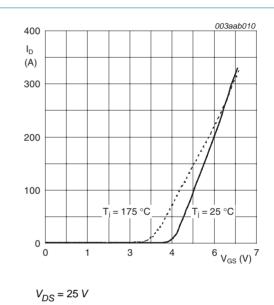


Fig 7. Transfer characteristics: drain current as a function of gate-source voltage; typical values

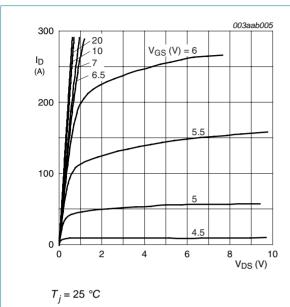
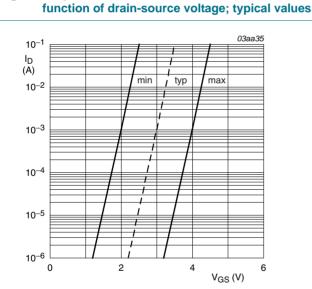
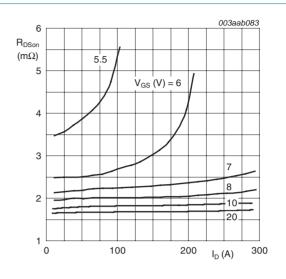


Fig 8. Output characteristics: drain current as a



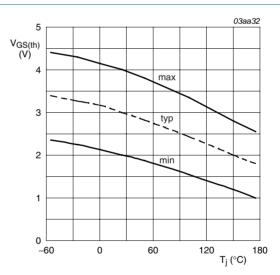
 $T_i = 25$ °C; $V_{DS} = V_{GS}$

Fig 10. Sub-threshold drain current as a function of gate-source voltage



$$T_j = 25 \, ^{\circ}C$$

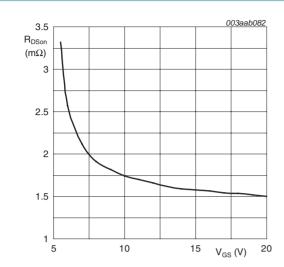
Fig 9. Drain-source on-state resistance as a function of drain current; typical values



$$I_D = 1 \text{ mA}; V_{DS} = V_{GS}$$

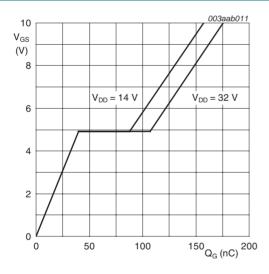
Fig 11. Gate-source threshold voltage as a function of junction temperature

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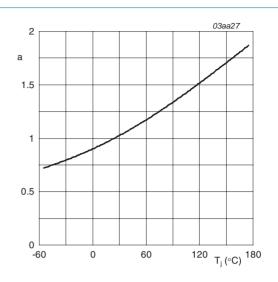
$$T_j = 25 \text{ °C}; I_D = 25 \text{ A}$$

Fig 12. Drain-source on-state resistance as a function of gate-source voltage; typical values



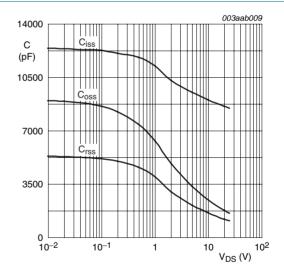
 $T_i = 25 \text{ °C}; I_D = 25 \text{ A}$

Fig 14. Gate-source voltage as a function of gate charge; typical values



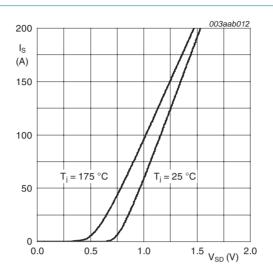
$$a = \frac{R_{DSon}}{R_{DSon(25^{\circ}C)}}$$

Fig 13. Normalized drain-source on-state resistance factor as a function of junction temperature



 $V_{GS} = 0 V$; f = 1 MHz

Fig 15. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



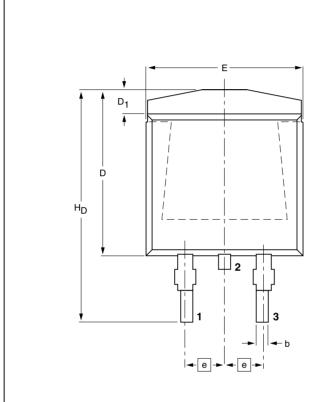
 $V_{GS} = 0 V$

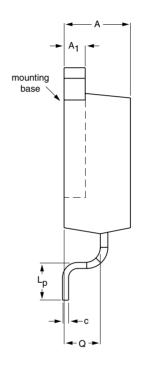
Fig 16. Source current as a function of source-drain voltage; typical values

7. Package outline

Plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped)

SOT404





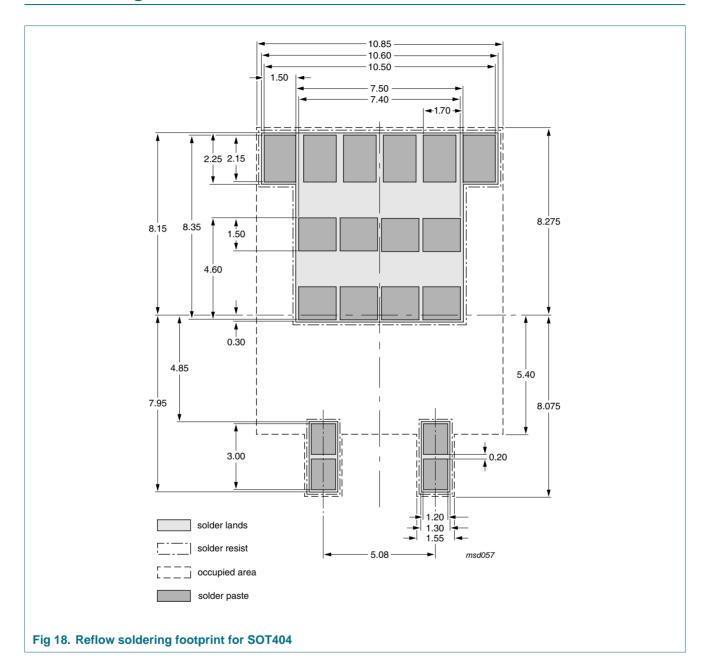
DIMENSIONS (mm are the original dimensions)

UNIT	A	A ₁	b	С	D max.	D ₁	E	е	Lp	Н _D	Q
mm	4.50 4.10	1.40 1.27	0.85 0.60	0.64 0.46	11	1.60 1.20	10.30 9.70	2.54	2.90 2.10	15.80 14.80	2.60 2.20

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE
SOT404					05-02-11 06-03-16

Fig 17. Package outline SOT404 (D2PAK)

8. Soldering





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N-channel TrenchMOS standard level FET

Revision history

Table 7. **Revision history**

Product data sheet

Document ID	Release date	Data sheet status	Change notice	Supersedes
BUK762R0-40C_2	20070820	Product data sheet	-	BUK762R0-40C_1
Modifications:		of this data sheet has beer of NXP Semiconductors.	redesigned to comply w	vith the new identity
	 Legal texts 	have been adapted to the	new company name whe	ere appropriate.
BUK762R0-40C_1	20060810	Product data sheet	-	-

10. Legal information

10.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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For additional information, please visit: http://www.nxp.com

For sales office addresses, send an email to: salesaddresses@nxp.com

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